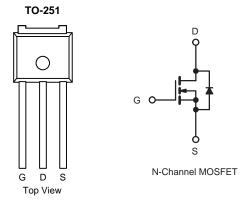


N-Channel 30-V (D-S) MOSFET

| PRODUCT SUMMARY | | | | |
|---------------------|------------------------------|--------------------|-----------------------|--|
| V _{DS} (V) | $R_{DS(on)}$ ($m\Omega$) | I _D (A) | Q _g (Typ.) | |
| 30 | 7 at V _{GS} = 10 V | 50 | 19 nC | |
| 30 | 9 at V _{GS} = 4.5 V | 45 | 19110 | |



FEATURES

- Halogen-free
- TrenchFET® Gen III Power MOSFET
- 100 % R_g Tested
 100 % UIS Tested

APPLICATIONS

- DC/DC Conversion
 - System Power

| Parameter | | Symbol | Limit | Unit |
|---|---------------|-----------------------------------|--|------|
| Drain-Source Voltage | | V_{DS} | 30 | V |
| Gate-Source Voltage | | V_{GS} | ± 20 | v |
| Continuous Drain Current ($T_J = 150 ^{\circ}\text{C}$) $T_C = T_C = T$ | | - I _D | 50 45 14 ^{b, c} 10 ^{b, c} | A |
| T _A = 70 °C Pulsed Drain Current | | I _{DM} | 150 | |
| Avalanche Current | L = 0.1 mH | I _{AS} | 25 | |
| Avalanche Energy | L = 0.1 IIII1 | E _{AS} | 40 | mJ |
| Continuous Source-Drain Diode Current $ T_{C} = 25 \text{ °C} $ $ T_{A} = 25 \text{ °C} $ | | I _S | 15 2.9 ^{b, c} | Α |
| | | P _D | 28 18 3.5 ^{b, c} 2.2 ^{b, c} | w |
| Operating Junction and Storage Temperature Range | | T _J , T _{stg} | - 55 to 150 | °C |
| Soldering Recommendations (Peak Tempera | ature) | | 260 | |

| THERMAL RESISTANCE RAT | TINGS | | | | |
|----------------------------------|--------------|-------------------|---------|---------|-------|
| Parameter | | Symbol | Typical | Maximum | Unit |
| Maximum Junction-to-Ambient | t ≤ 10 s | R _{thJA} | 29 | 36 | °C/W |
| Maximum Junction-to-Case (Drain) | Steady State | R_{thJC} | 3.6 | 4.5 | O/ VV |

- a. Based on T_C = 25 °C.
 b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.



| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit |
|---|-------------------------|--|------|------|-------|----------|
| Static | | | | • | • | |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | 30 | | | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | I _D = 250 μA | | 33 | | m\//°C |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | I _D = 250 μA | | - 5 | | mV/°C |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$ | 1.2 | | 3.0 | V |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ | | | ± 100 | nA |
| Zana Cata Valtana Duain Comment | 1 | $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$ | | | 1 | μΑ |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C | | | 5 | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$ | 15 | | | Α |
| Dunin Course On Chata Desistance | | V _{GS} = 10 V, I _D = 10 A | | 7 | | m() |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | $V_{GS} = 4.5 \text{ V}, I_D = 7 \text{ A}$ | | 9 | | mΩ |
| Forward Transconductance ^a | g _{fs} | V _{DS} = 15 V, I _D = 10 A | | 24 | | S |
| Dynamic ^b | | | ' | • | | <u> </u> |
| Input Capacitance | C _{iss} | | | 1700 | | |
| Output Capacitance | C _{oss} | $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | | 200 | | pF |
| Reverse Transfer Capacitance | C _{rss} | | | 150 | | |
| Total Oats Ohanna | Qg | V _{DS} = 15 V, V _{GS} = 10 V, I _D = 10 A | | 33 | | nC |
| Total Gate Charge | | | | 18 | | |
| Gate-Source Charge | Q _{gs} | $V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$ | | 7.3 | | |
| Gate-Drain Charge | Q _{gd} | | | 6.2 | | |
| Gate Resistance | R_g | f = 1 MHz | 0.2 | 0.8 | 1.6 | Ω |
| Turn-On Delay Time | t _{d(on)} | | | 15 | 30 | |
| Rise Time | t _r | V_{DD} = 15 V, R_L = 1.5 Ω | | 12 | 24 | |
| Turn-Off Delay Time | t _{d(off)} | $V_{DD} = 15 \text{ V, } R_L = 1.5 \Omega$ $I_D \cong 10 \text{ A, } V_{GEN} = 4.5 \text{ V, } R_g = 1 \Omega$ | | 13 | 26 | |
| Fall Time | t _f | | | 10 | 20 | |
| Turn-On Delay Time | t _{d(on)} | | | 9 | 18 | ns |
| Rise Time | t _r | V_{DD} = 15 V, R_L = 1.5 Ω | | 9 | 18 | |
| Turn-Off Delay Time | t _{d(off)} | $I_D\cong 10$ A, $V_{GEN}=10$ V, $R_g=1$ Ω | | 14 | 28 | |
| Fall Time | t _f | | | 8 | 16 | |
| Drain-Source Body Diode Characteristi | cs | | ' | • | | <u>I</u> |
| Continuous Source-Drain Diode Current | I _S | T _C = 25 °C | | | 16 | ٨ |
| Pulse Diode Forward Current | I _{SM} | | | | 32 | A |
| Body Diode Voltage | V_{SD} | I _S = 3 A, V _{GS} = 0 V | | 0.78 | 1.2 | V |
| Body Diode Reverse Recovery Time | t _{rr} | | | 17 | 34 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | I _F = 10 A, dI/dt = 100 A/μs, T _{.I} = 25 °C | | 9.5 | 19 | nC |
| Reverse Recovery Fall Time | t _a | $I_F = 10 \text{ A}, \text{ al/at} = 100 \text{ A/}\mu\text{s}, I_J = 25 \text{ C}$ | | 10 | | |
| Reverse Recovery Rise Time | t _b | | | 7 | | ns |

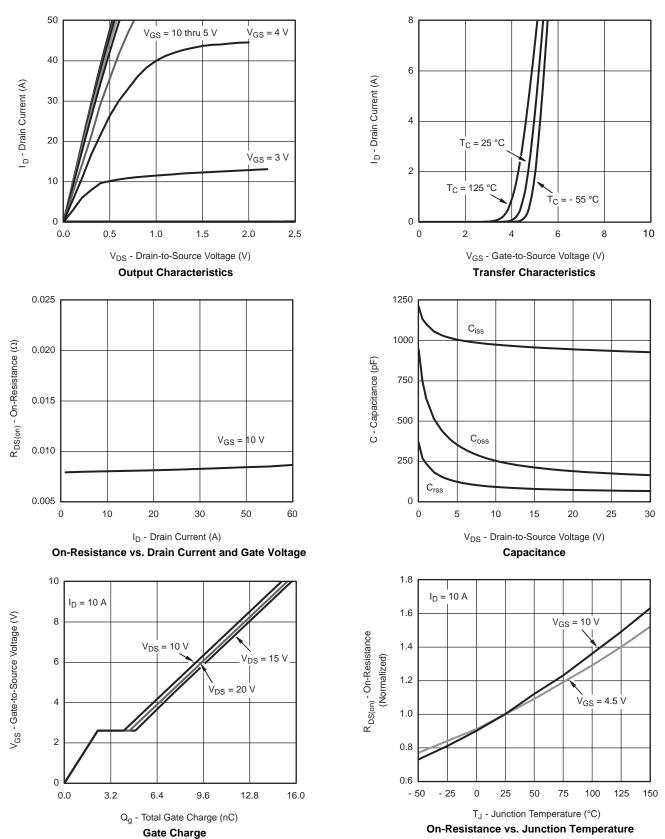
Notes:

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



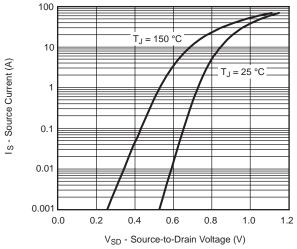
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



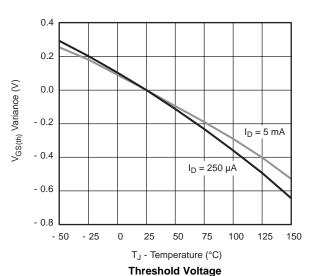


9

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Source-Drain Diode Forward Voltage



 $I_D = 10 \text{ A}$ $I_D = 10 \text$

0.06

0.00

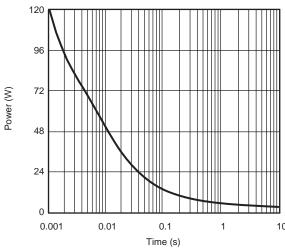
0 1

V_{GS} - Gate-to-Source Voltage (V)

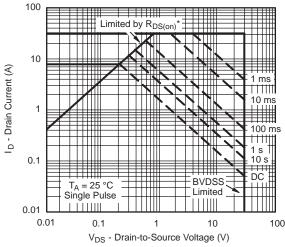
On-Resistance vs. Gate-to-Source Voltage

4 5

2 3



Single Pulse Power (Junction-to-Ambient)

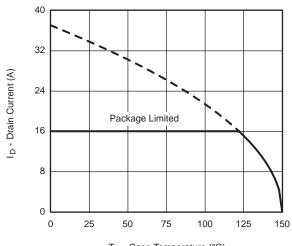


* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient

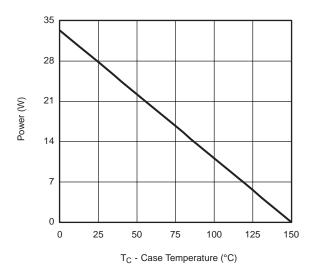


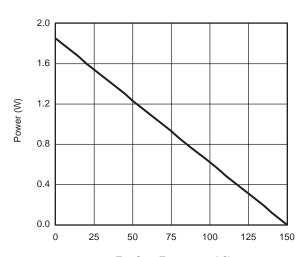
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T_C - Case Temperature (°C)

Current Derating*





T_A - Case Temperature (°C)

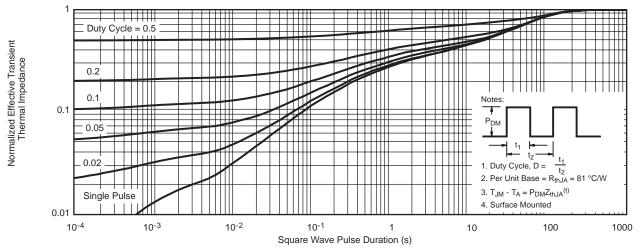
Power, Junction-to-Case

Power, Junction-to-Ambient

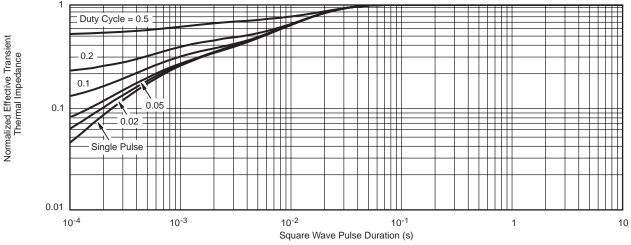
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient

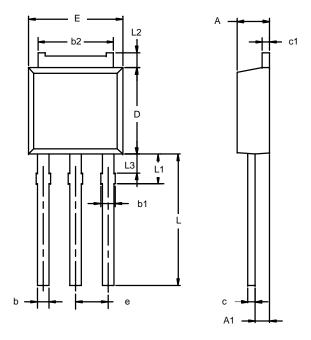


Normalized Thermal Transient Impedance, Junction-to-Case

6



TO-251AA (DPAK)



| Note: | Dimension | L3 is for | reference only. |
|-------|-----------|-----------|-----------------|
|-------|-----------|-----------|-----------------|

| | MILLIM | IETERS | INC | HES | |
|---------------------|--------------------|-------------|-----------|-------|--|
| Dim | Min | Max | Min | Max | |
| Α | 2.21 | 2.38 | 0.087 | 0.094 | |
| A 1 | 0.89 | 1.14 | 0.035 | 0.045 | |
| b | 0.71 | 0.89 | 0.028 | 0.035 | |
| b1 | 0.76 | 1.14 | 0.030 | 0.045 | |
| b2 | 5.23 | 5.43 | 0.206 | 0.214 | |
| С | 0.46 | 0.58 | 0.018 | 0.023 | |
| с1 | 0.46 | 0.58 | 0.018 | 0.023 | |
| D | 5.97 | 6.22 | 0.235 | 0.245 | |
| Е | 6.48 | 6.73 | 0.255 | 0.265 | |
| е | 2.28 | BSC | 0.090 BSC | | |
| L | 3.89 | 9.53 | 0.153 | 0.375 | |
| L1 | 1.91 | 2.28 | 0.075 | 0.090 | |
| L2 | 0.89 | 1.27 | 0.035 | 0.050 | |
| L3 | 1.15 | 1.52 | 0.045 | 0.060 | |
| ECN: S-0 DWG: 53 | 3946—Rev. E 346 | , 09-Jul-01 | | | |



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